



QPA1022D

8.5 – 11 GHz 4 W GaN Power Amplifier

Product Overview

Qorvo's QPA1022D is a MMIC power amplifier fabricated on Qorvo's production 0.15 μm GaN on SiC process (QGaN15). Covering 8.5–11.0 GHz, the QPA1022D provides > 4 W of saturated output power and 24 dB of large-signal gain while achieving 45% power-added efficiency.

The QPA1022D is matched to 50 Ω with integrated DC blocking capacitors at RF output and DC grounded input port. It also has a built-in power detector for system RF power checking. With a compact dimension of 2.65 x 1.25 x 0.10 mm, it can support tight lattice spacing requirements for phased array radar applications. It is also an ideal component to support test instrumentation and commercial communication systems.



Key Features

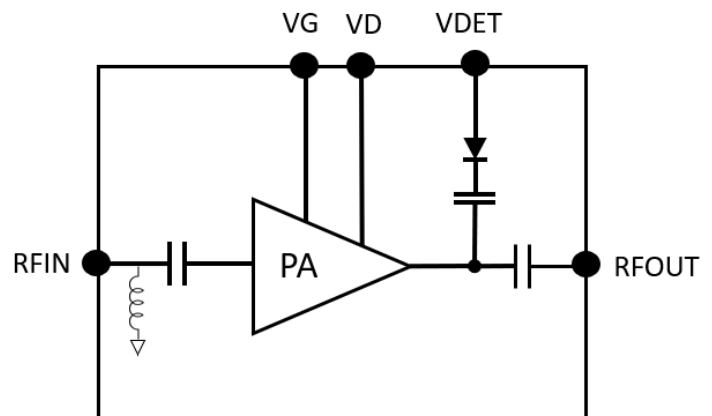
- Frequency Range: 8.5 – 11 GHz
- P_{SAT} ($P_{IN}=12$ dBm): 36 dBm
- PAE ($P_{IN}=12$ dBm): 45 %
- Power Gain ($P_{IN}=12$ dBm): 24 dB
- Small Signal Gain: 31 dB
- Bias: $V_D = 22$ V, $I_{DQ} = 180$ mA
- Die Dimensions: 2.65 x 1.25 x 0.10 mm

Performance is typical across frequency. Please reference electrical specification table and data plots for more details.

Applications

- Radar
- Electronic Warfare
- Communications

Functional Block Diagram



Ordering Information

Part No.	Description
QPA1022D	8.5 to 11 GHz 4 W GaN Power Amplifier
QPA1022DS2	Device Sample (2 pcs)
QPA1022DEVB	Evaluation Board for QPA1022D

Absolute Maximum Ratings

Parameter	Value / Range	Units
Drain Voltage (V_D)	28	V
Gate Voltage Range (V_G)	-5 to 0	V
Drain Current (I_D)	600	mA
Gate Current (I_G)	10	mA
Input Power (P_{IN}), 3:1 VSWR, $V_D=22$ V, $I_{DQ}=180$ mA, 85 °C	27	dBm
Storage Temperature	-55 to +150	°C

Exceeding any one or a combination of the Absolute Maximum Rating conditions may cause permanent damage to the device. Extended application of Absolute Maximum Rating conditions to the device may reduce device reliability.

Recommended Operating Conditions

Parameter	Value / Range	Units
Drain Voltage (V_D)	22	V
Drain Current (I_{DQ})	180	mA
Operating Temperature	- 40 to + 85	°C

Electrical specifications are measured at specified test conditions. Specifications are not guaranteed over all recommended operating conditions.

Electrical Specifications

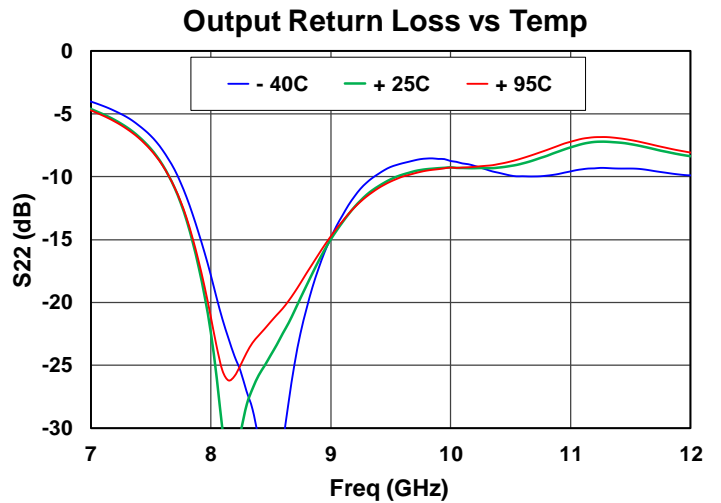
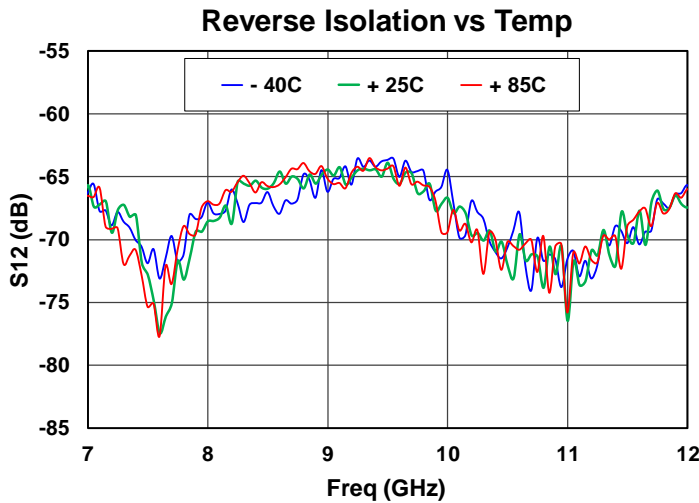
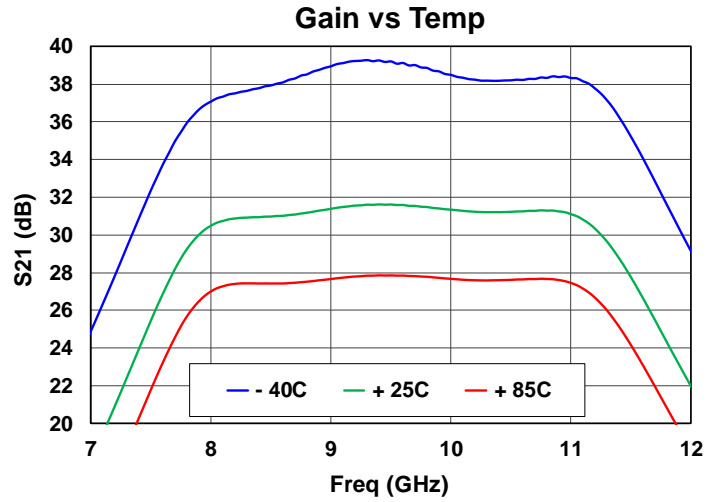
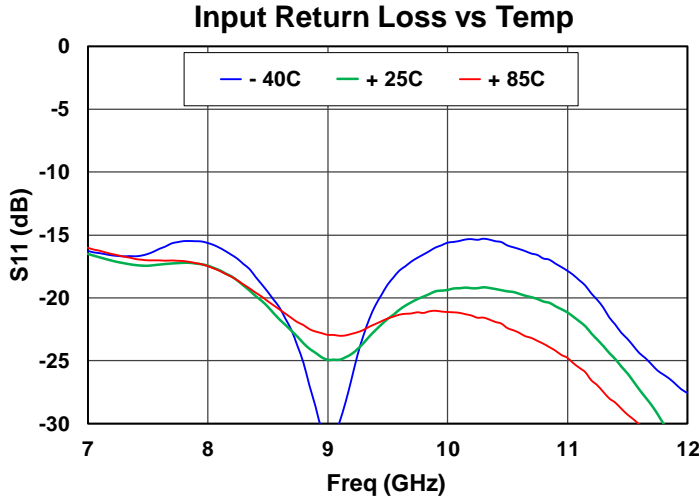
Test conditions unless otherwise noted: Temp = 25 °C, $V_D = 22$ V, $I_{DQ} = 180$ mA. Data de-embedded to the reference planes.

Parameter	Min	Typ	Max	Units
Operational Frequency	8.5		11	GHz
Output Power (Pulse and CW, $P_{IN}=12$ dBm)		36.5		dBm
Power Added Efficiency (Pulse and CW, $P_{IN}= 12$ dBm)		45		%
Large Signal Gain (Pulse and CW, $P_{IN}=12$ dBm)		24.5		dB
Small Signal Gain		31		dB
Input Return Loss		17		dB
Output Return Loss		7		dB
Harmonic Suppression (CW @ $P_{OUT} = 36$ dBm, $2f_0$)		27		dBc
P_{OUT} Temp. Coeff. ($P_{IN} = 12$ dBm)		-0.001		dB/°C
Small Signal Gain Temp. Coefficient		-0.087		dB/°C

Note: For pulse power, Pulse Width = 100 μ S, Duty Cycle = 10%

Performance Plots – Small Signal

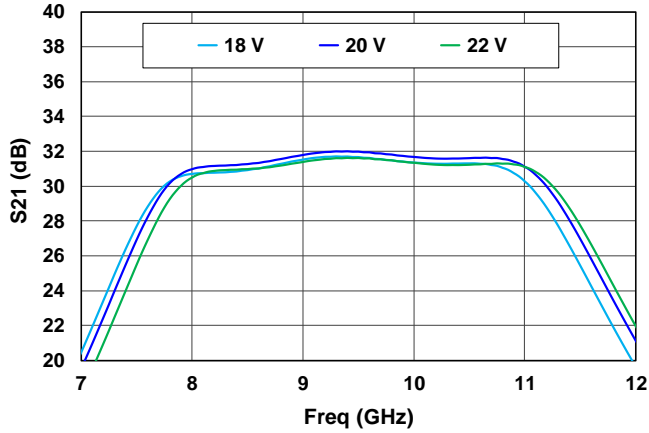
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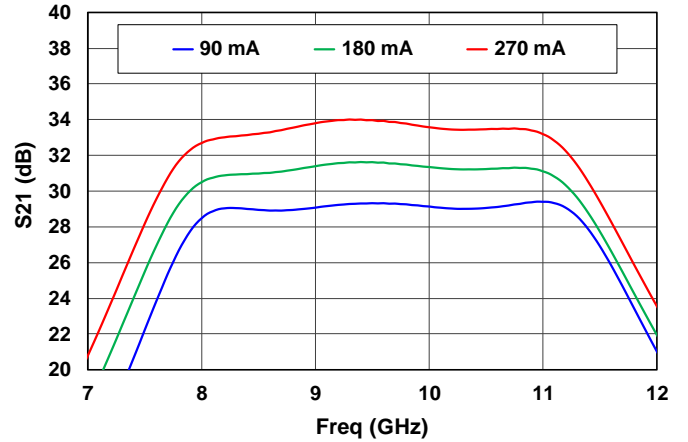
Performance Plots – Small Signal

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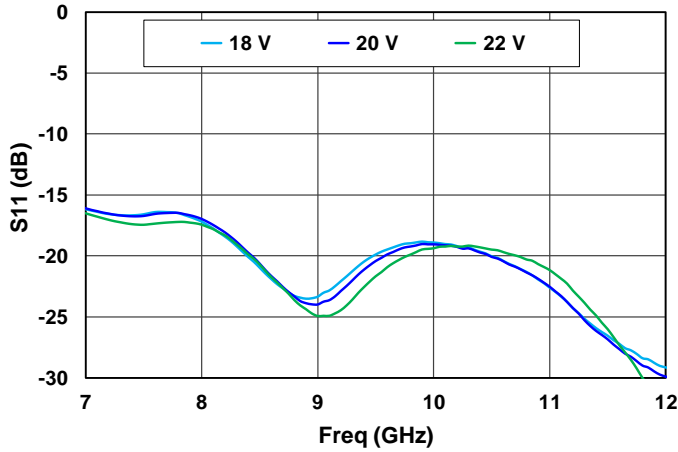
Gain vs Voltage



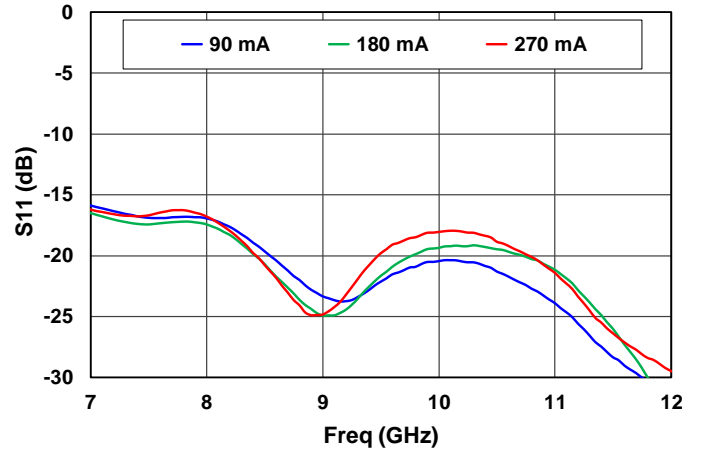
Gain vs Current



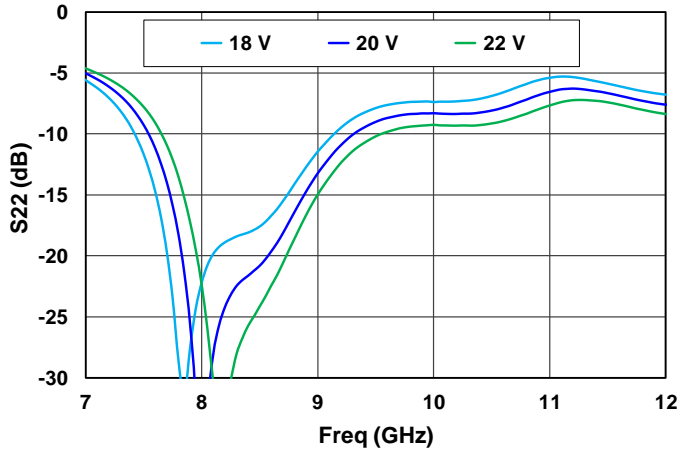
Input Return Loss vs Voltage



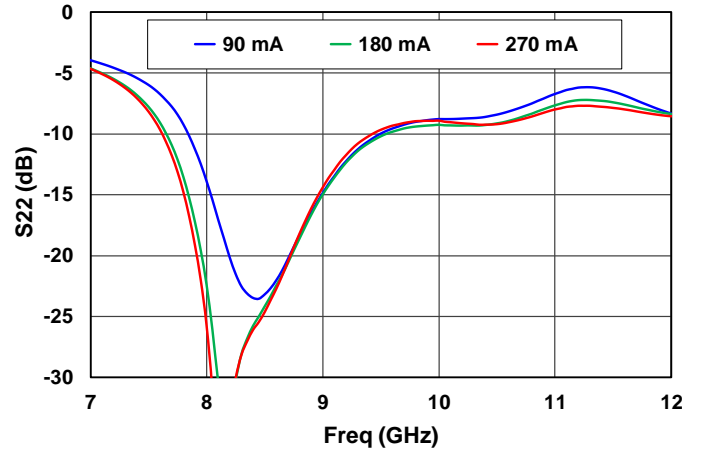
Input Return Loss vs Current



Output Return Loss vs Voltage

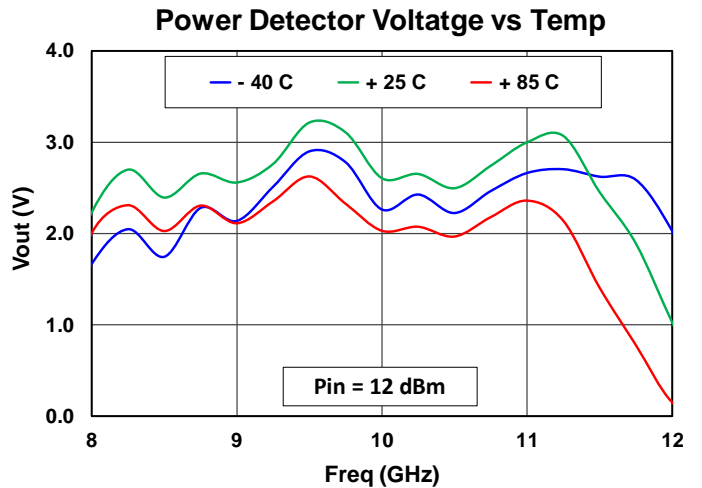
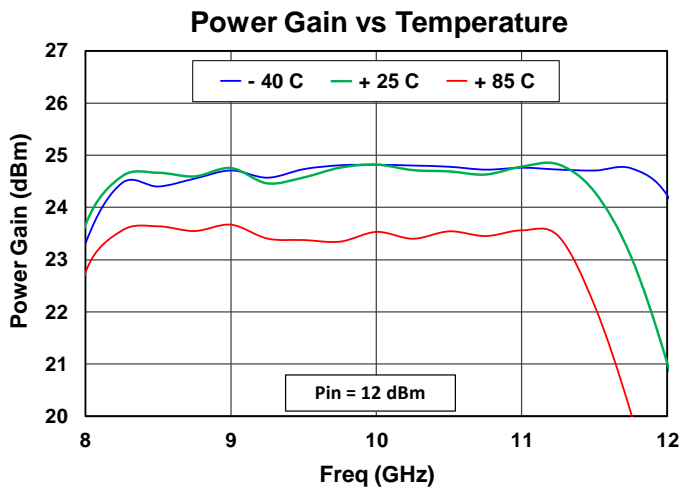
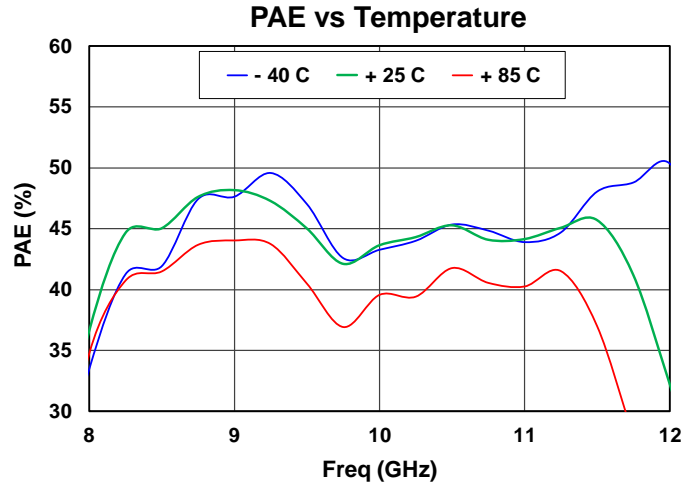
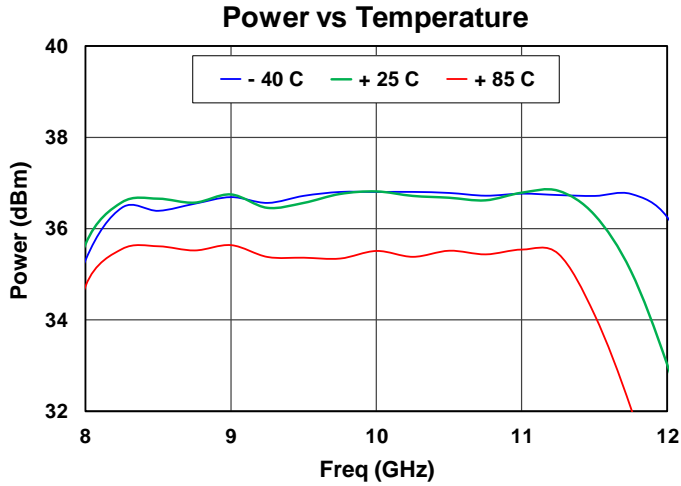


Output Return Loss vs Current



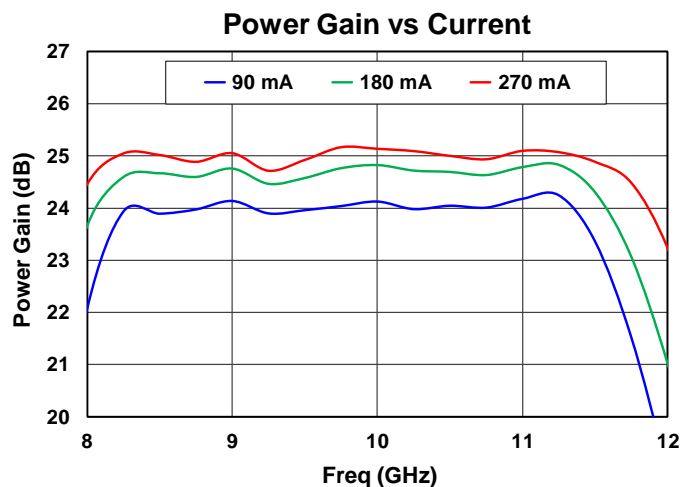
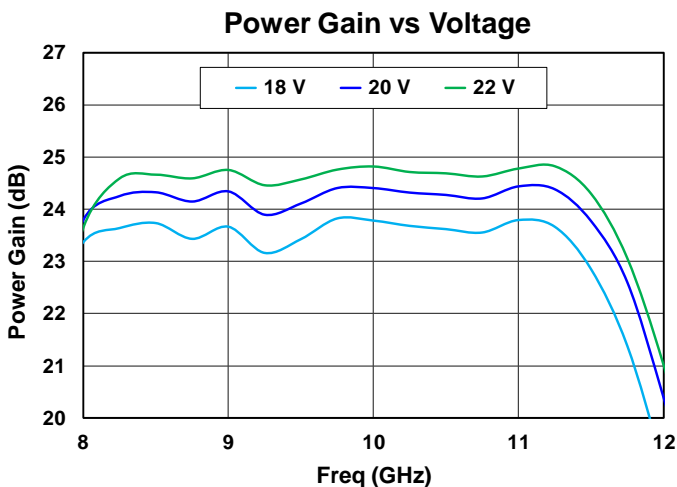
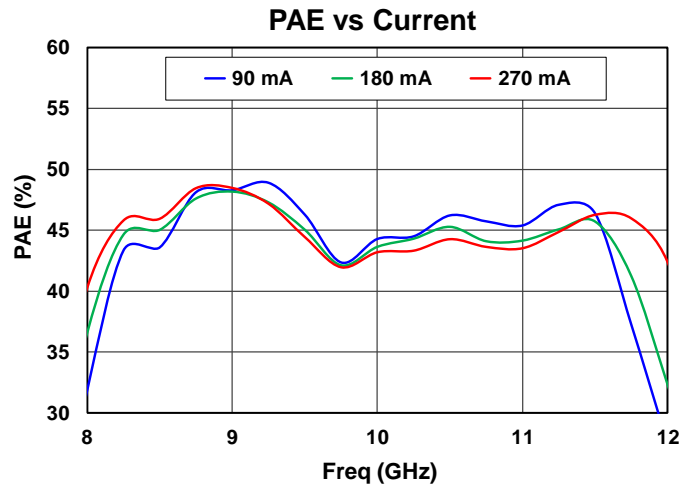
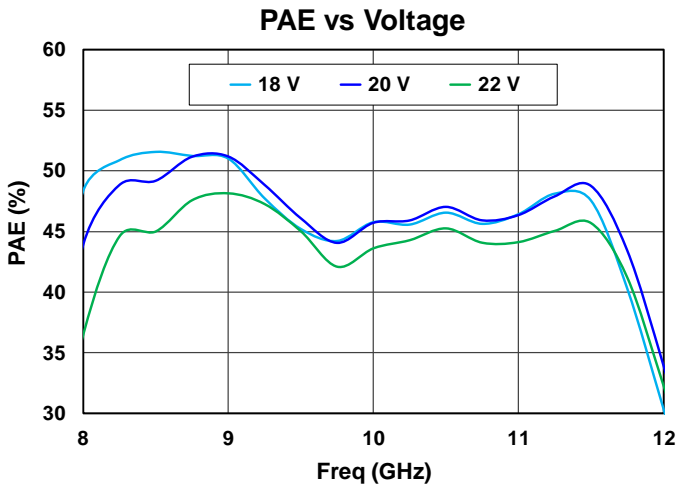
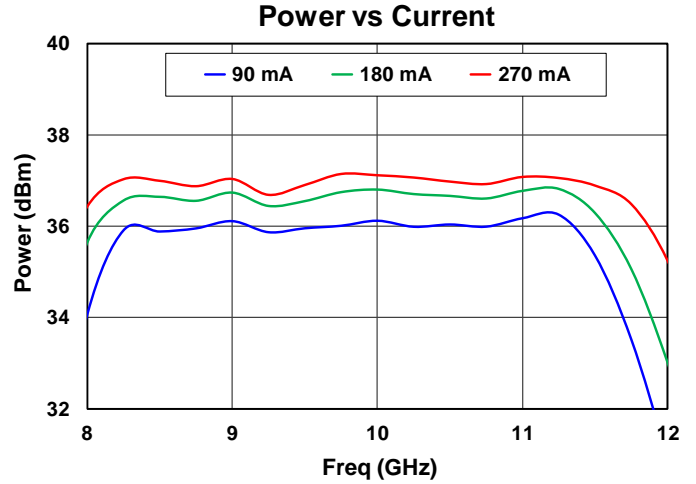
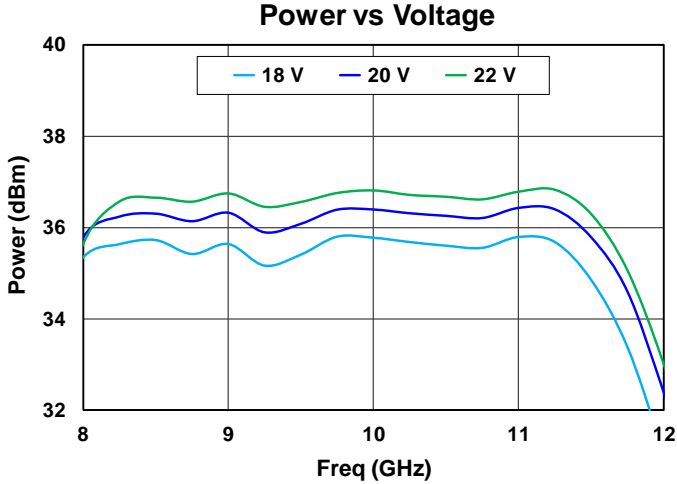
Performance Plots – Large Signal, Pulse

Test conditions unless otherwise noted: $V_D = 22\text{ V}$, $I_{BQ} = 180\text{ mA}$, $P_{in} = 12\text{ dBm}$, Pulse Width = 100 μs , DC = 10%, Temp = + 25 °C



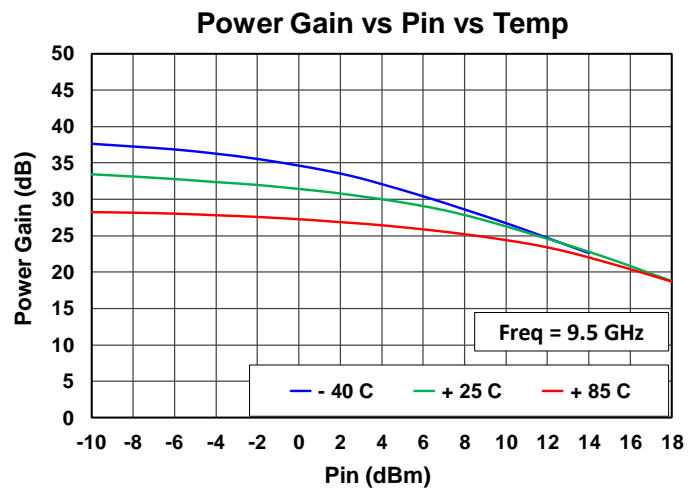
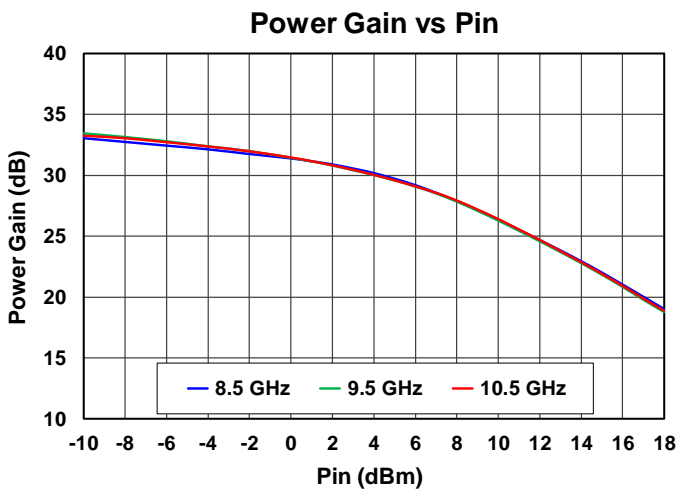
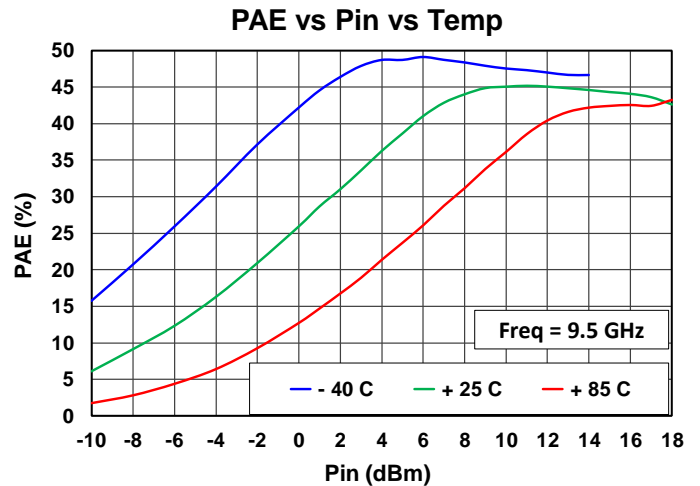
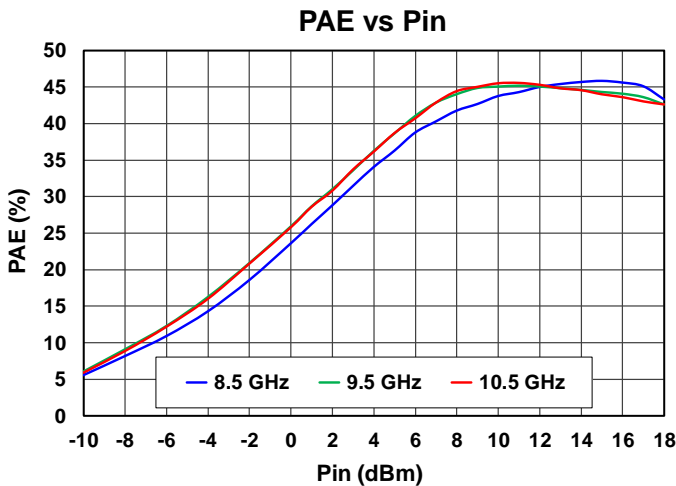
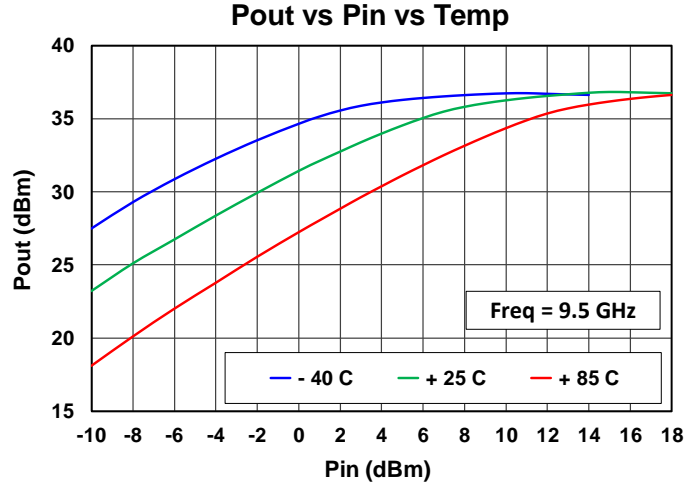
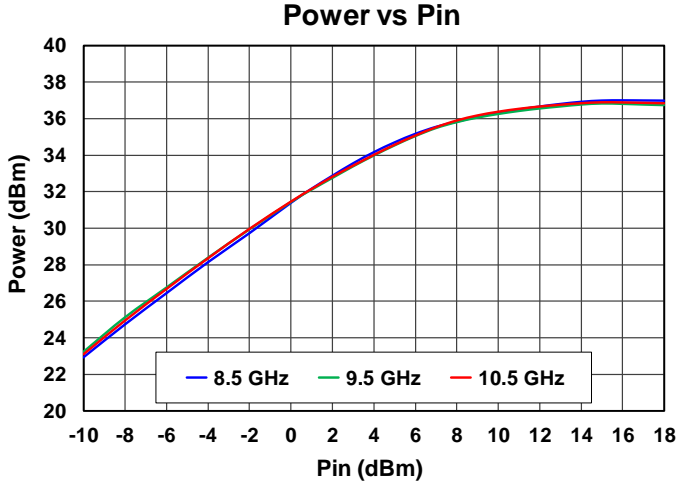
Performance Plots – Large Signal, Pulse

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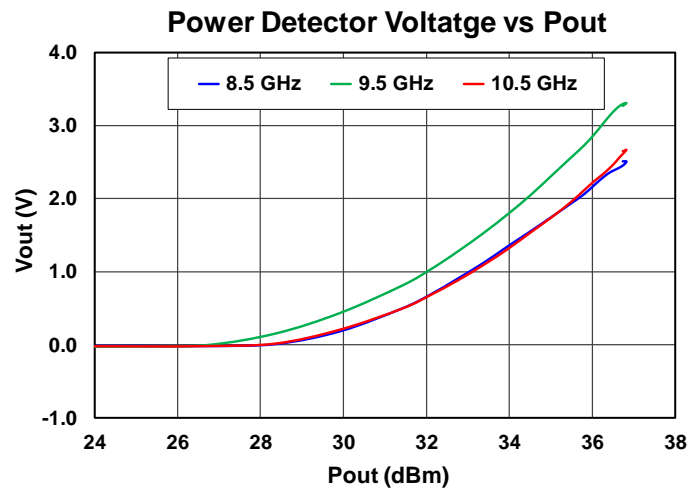
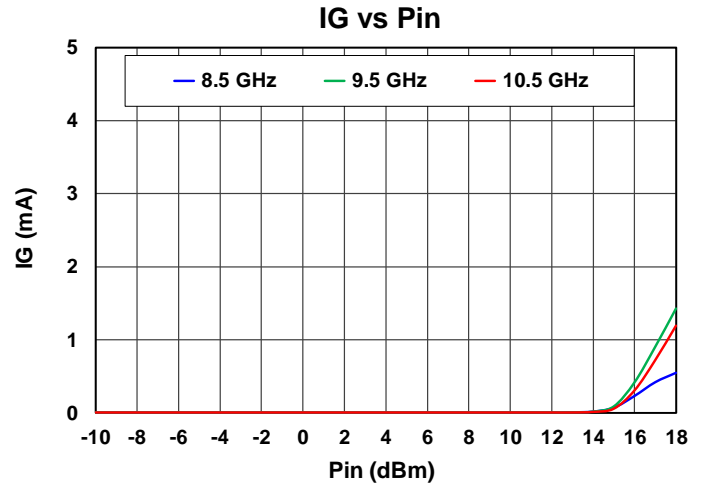
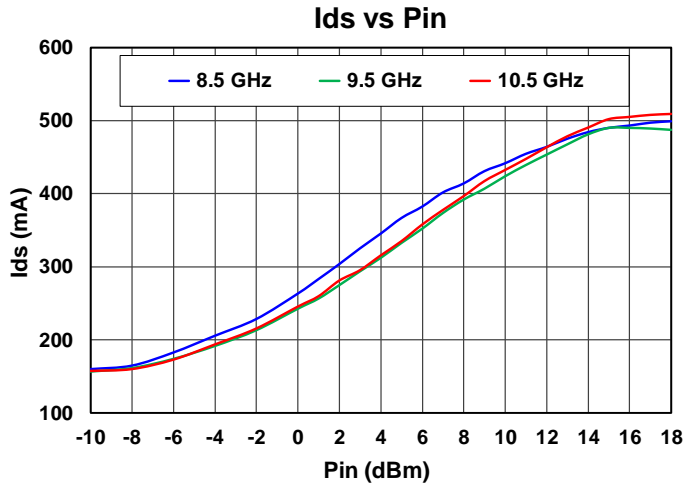
Performance Plots – Large Signal, Pulse

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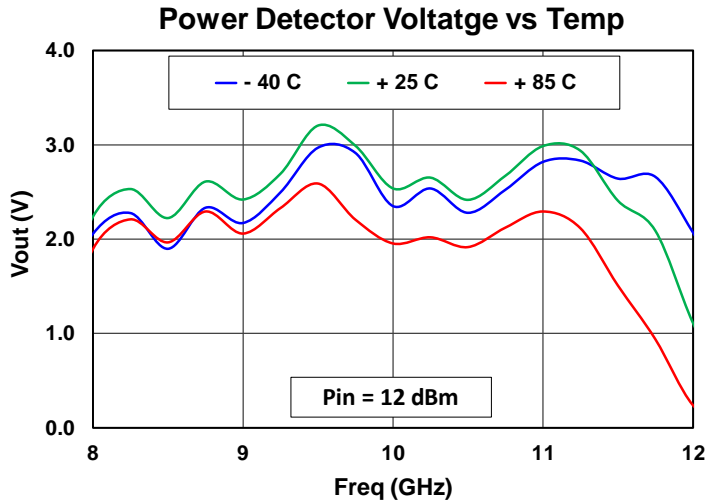
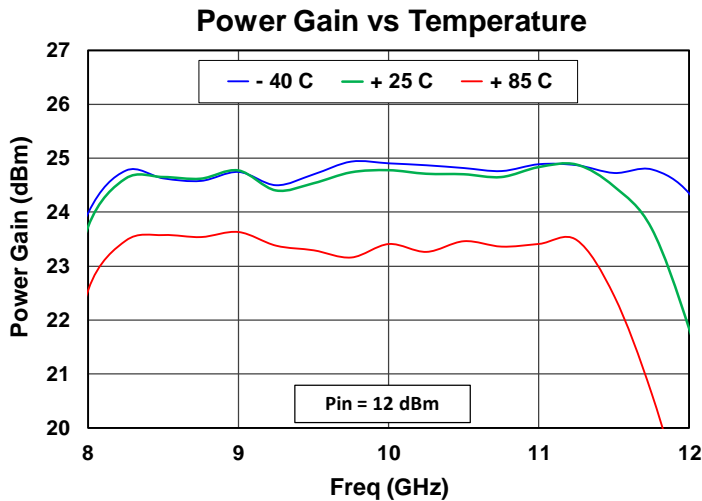
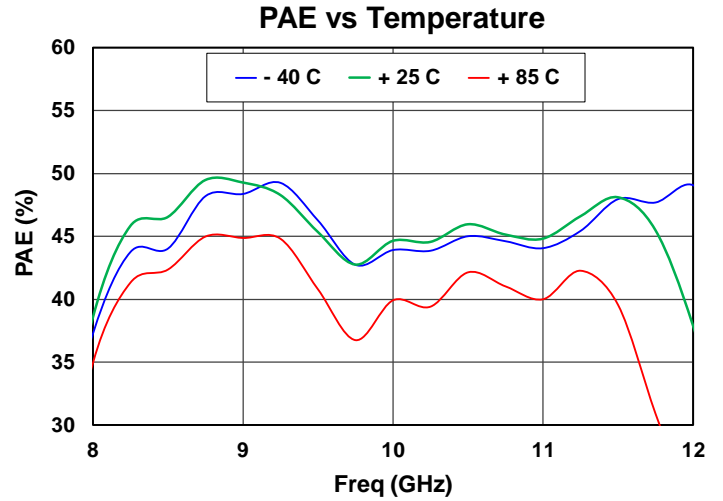
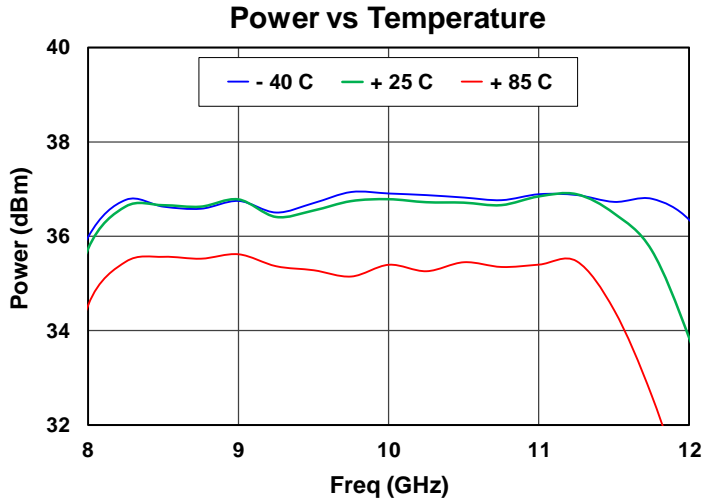
Performance Plots – Large Signal, Pulse

Test conditions unless otherwise noted: $V_D = 22\text{ V}$, $I_{DQ} = 180\text{ mA}$, $P_{in} = 12\text{ dBm}$, Pulse Width = 100 μs , DC = 10%, Temp = + 25 °C



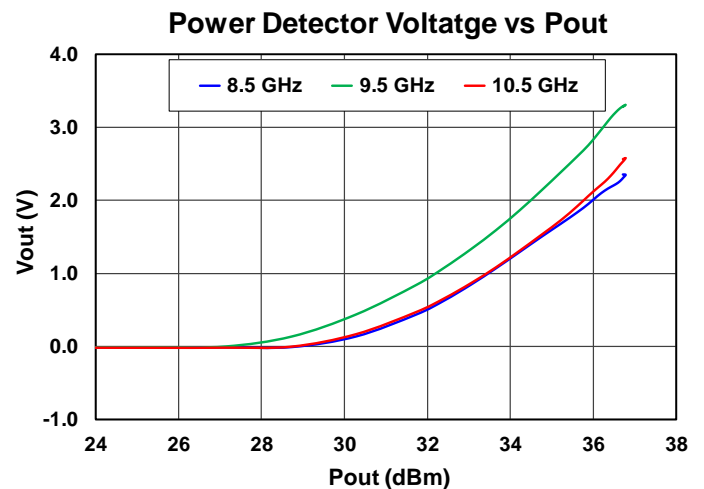
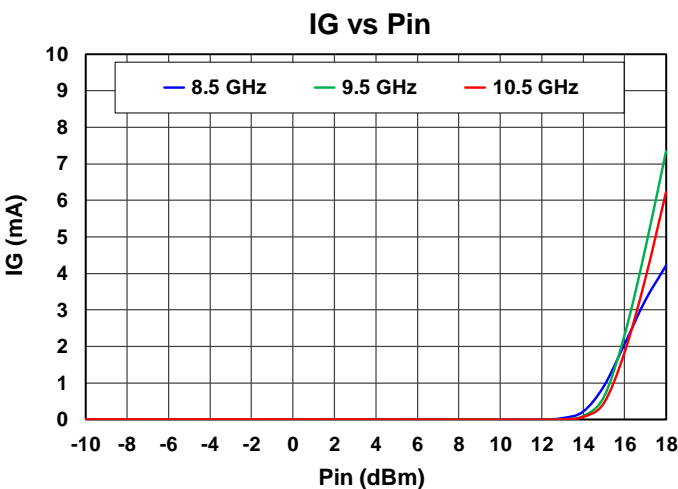
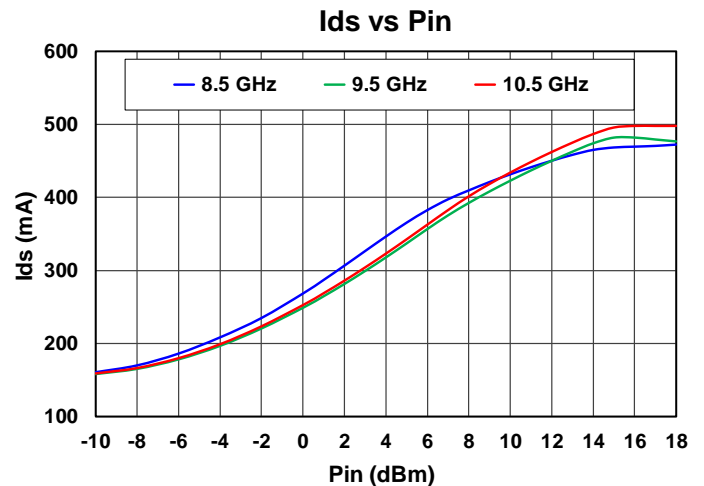
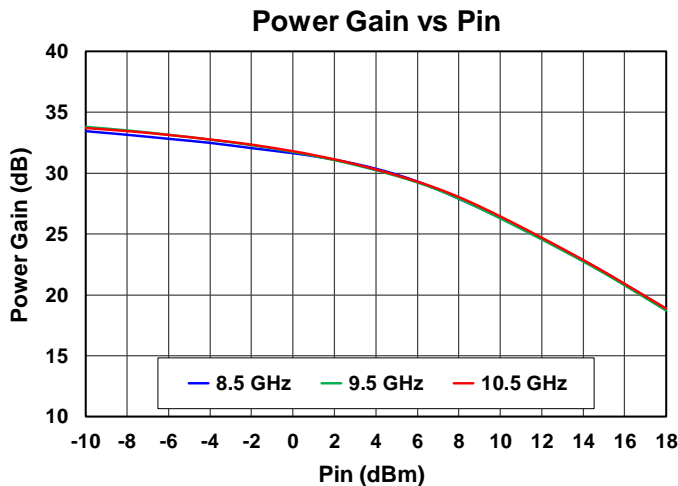
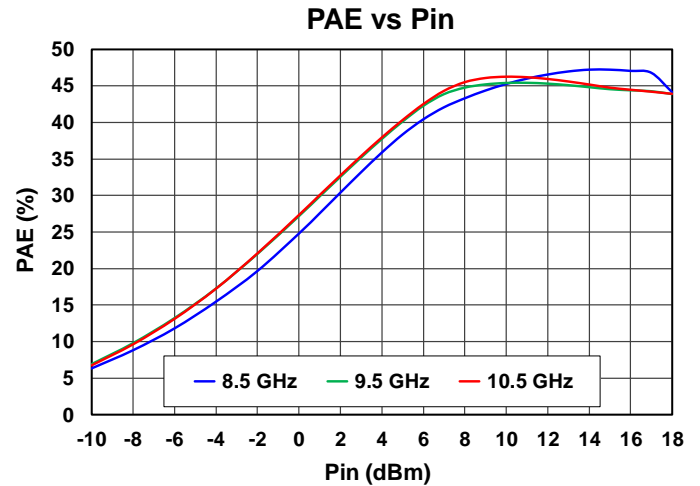
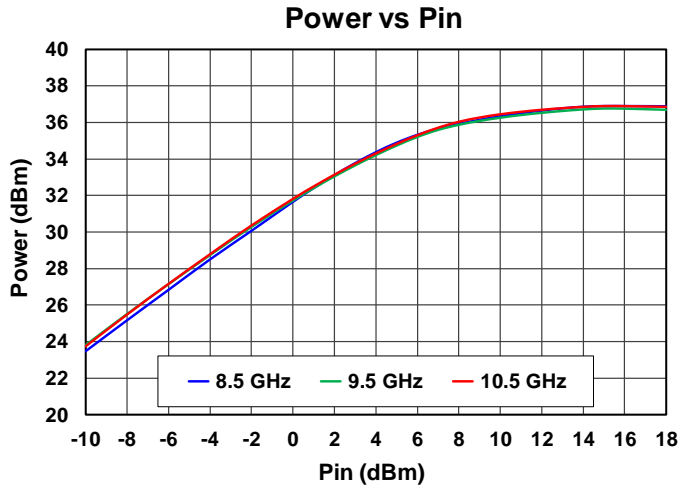
Performance Plots – Large Signal, CW

Test conditions unless otherwise noted: $V_D = 22\text{ V}$, $I_{DQ} = 180\text{ mA}$, $P_{in} = 12\text{ dBm}$, Temperature = $+25\text{ }^\circ\text{C}$



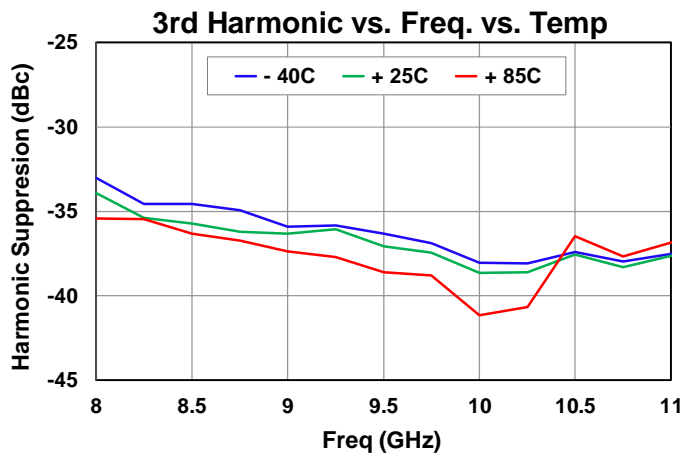
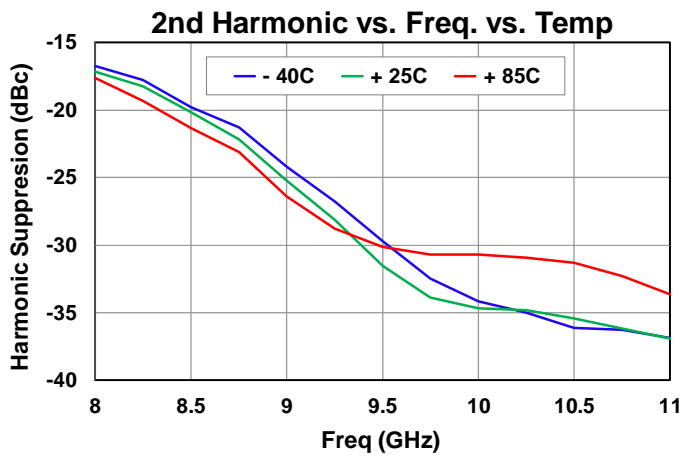
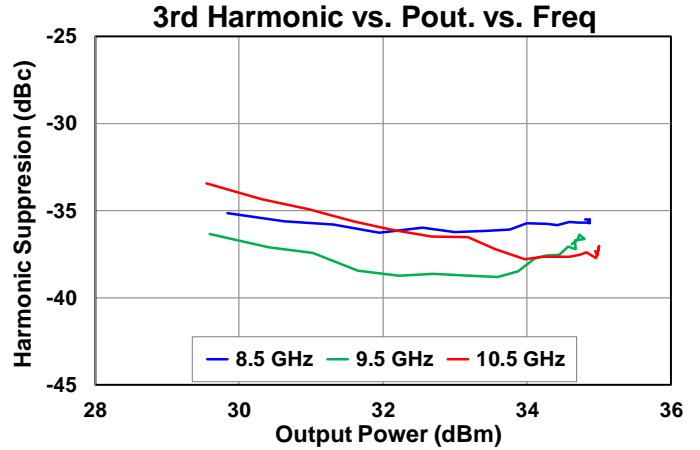
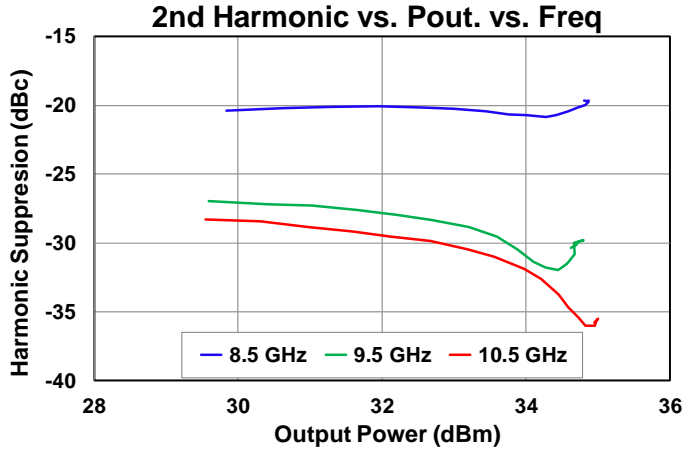
Performance Plots – Large Signal, CW

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Performance Plots – HarmonicSuppressions, CW

Test conditions otherwise noted: $V_D = 22\text{ V}$, $I_{DQ} = 180\text{ mA}$, $P_{in} = 12\text{ dBm}$, Temperature = + 25 °C



Thermal and Reliability Information

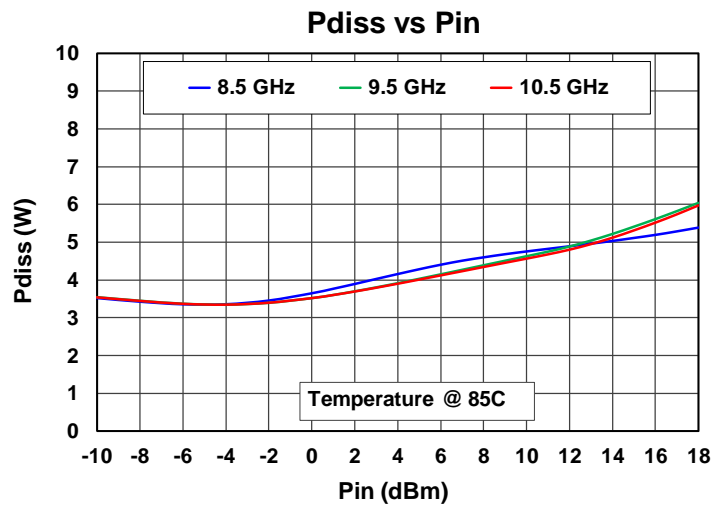
Parameter	Test Conditions	Value	Units
Thermal Resistance (θ_{JC}) ⁽¹⁾	$T_{base} = 85\text{ }^{\circ}\text{C}$, $V_D = 22\text{ V}$, $I_{DQ} = 180\text{ mA}$, $P_{DISS} = 3.96\text{ W}$, CW, No RF (quiescent DC operation)	8.3	$^{\circ}\text{C/W}$
Channel Temperature, T_{CH} (No RF) ⁽²⁾		118	$^{\circ}\text{C}$
Thermal Resistance (θ_{JC}) ⁽¹⁾	$T_{base} = 85\text{ }^{\circ}\text{C}$, $V_D = 22\text{ V}$, $I_{DQ} = 180\text{ mA}$, CW Freq = 9.5 GHz, $I_{D_Drive} = 0.472\text{ A}$, $P_{IN} = 18\text{ dBm}$, $P_{OUT} = 36.4\text{ dBm}$, $P_{DISS} = 6.08\text{ W}$	9.0	$^{\circ}\text{C/W}$
Channel Temperature, T_{CH} (Under RF) ⁽²⁾		140	$^{\circ}\text{C}$

Notes:

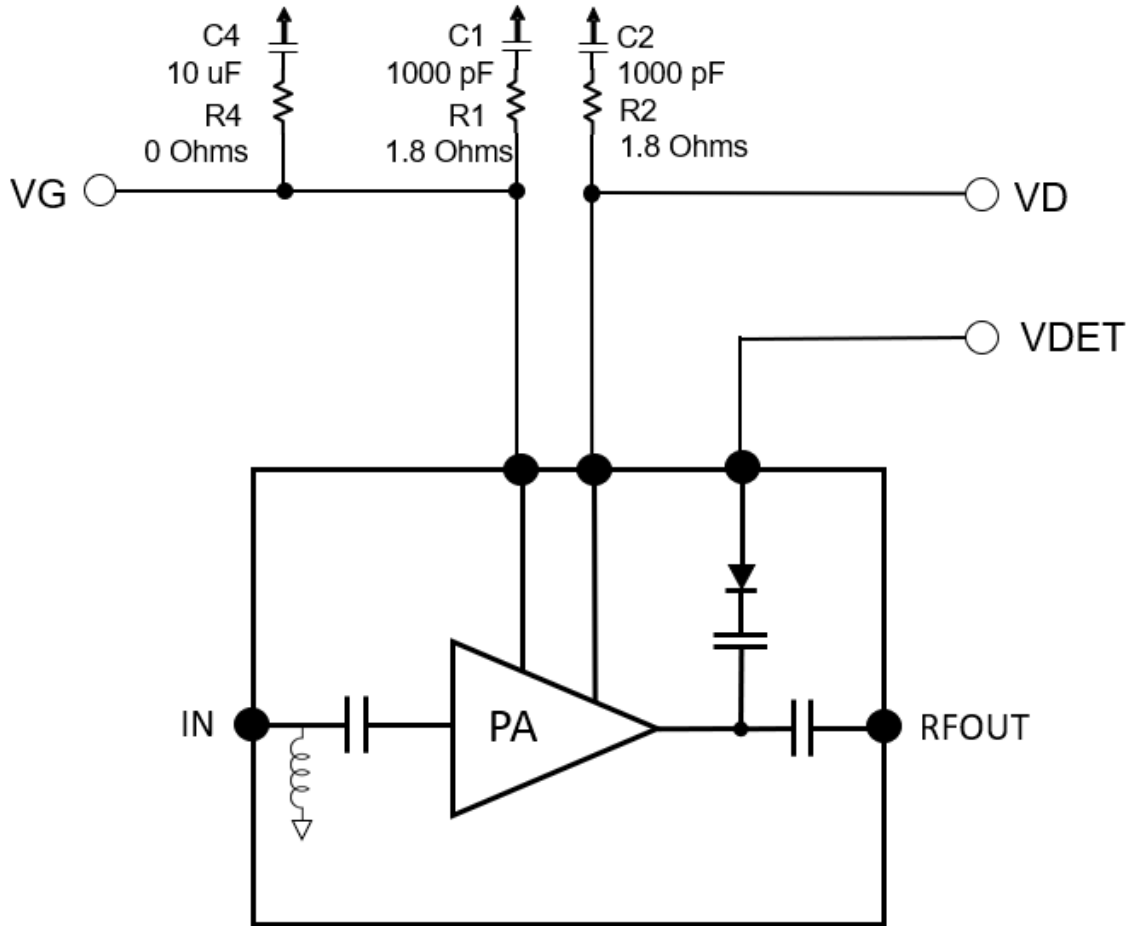
- Thermal resistance is referenced to the back of Cu-Mo carrier plate, assuming carrier thickness 20 mils, eutectic die attachment, back side of carrier temperature at 85 °C
- Refer to the following document: [GaN Device Channel Temperature, Thermal Resistance, and Reliability Estimates](#)

Dissipated Power under RF Drive

Test conditions otherwise noted: $V_D = 22\text{ V}$, $I_{DQ} = 180\text{ mA}$, CW, Temperature = +85 °C



Applications Information



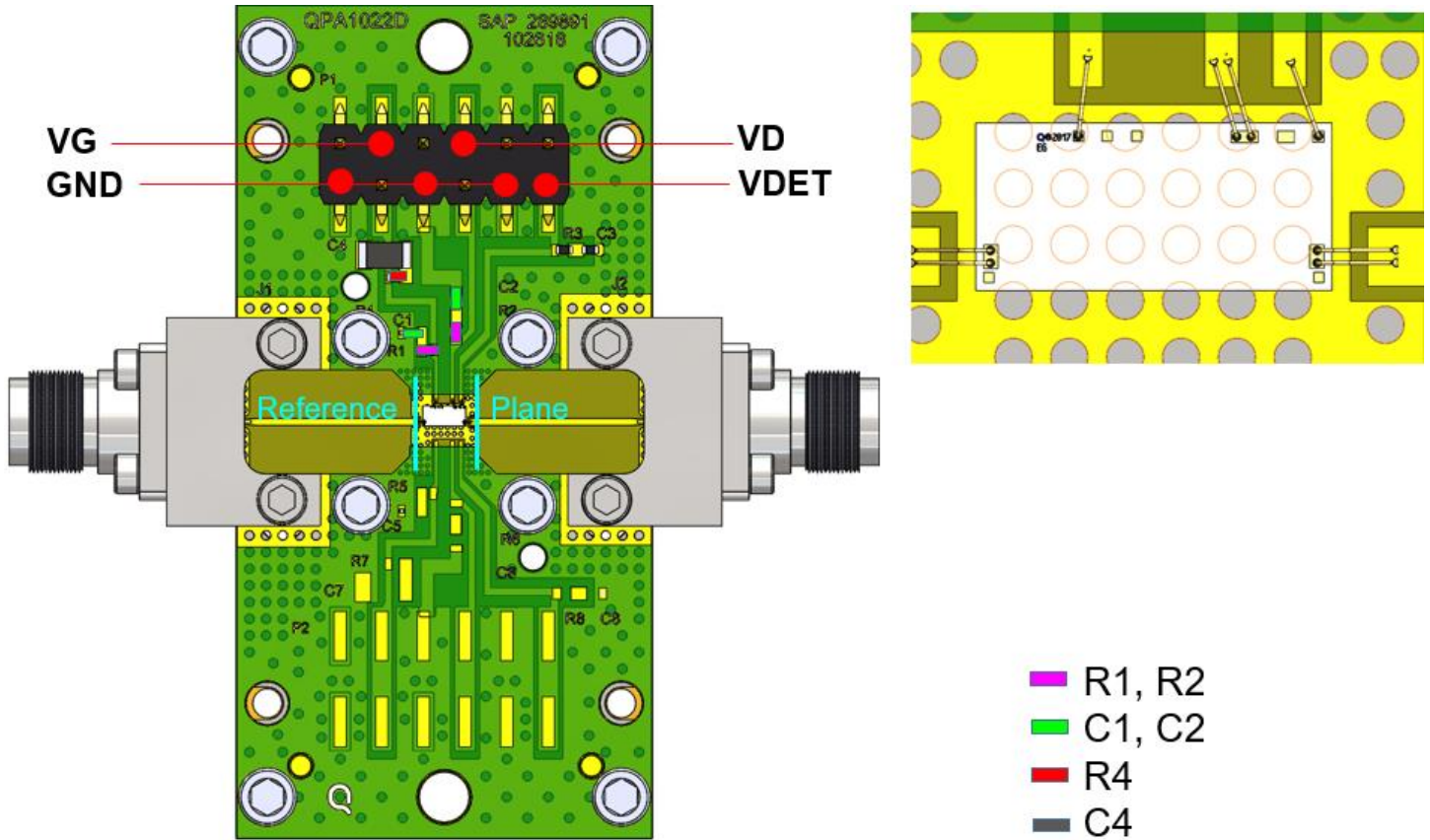
Bias-Up Procedure

1. Set I_D limit to 600 mA, I_G limit to 10 mA
2. Set V_G to -4.0 V
3. Set V_D +22 V
4. Adjust V_G more positive until $I_{DQ} \approx 180$ mA
5. Apply RF signal

Bias-Down Procedure

1. Turn off RF signal
2. Reduce V_G to -4.0 V. Ensure $I_{DQ} \sim 0$ mA
4. Set V_D to 0 V
5. Turn off V_D supply
6. Turn off V_G supply

Evaluation Board (EVB) Layout Assembly

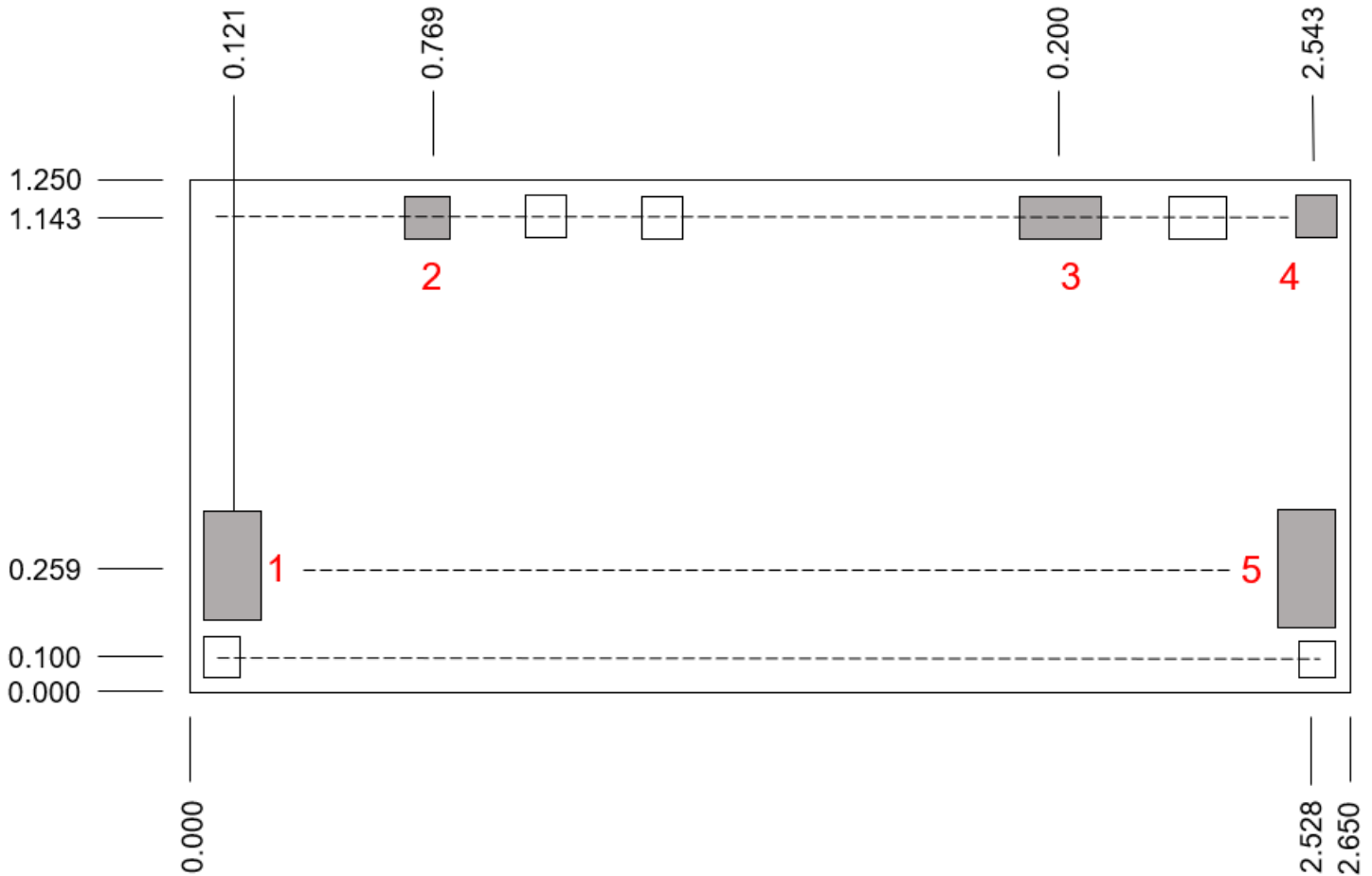


PCB is made from Rogers 4003C dielectric, 8 mil thickness, 0.5 oz. copper both sides.

Bill of Materials

Reference Des.	Value	Description	Manuf.	Part Number
C1, C2	1000 pF	CAP, 1000 pF, 20%, 50 V, 0402	Various	
R1, R2	1.8 Ohm	RES, 1.8 Ohm, 5%, 1/10 W, 0402	Various	
C4	10 uF	CAP, 10 uF, 20%, 50 V, 1206	Various	
R4	0 Ω	RES, 0 OHM, JMPR, 0402	Various	
J1, J2	2.92 mm	CONNECTOR, FEMALE, ENDLAUNCH	Southwest Microwave	1092-01A-5

Mechanical Information



Dimensions are in mm
Die thickness: 0.100
Die x, y size tolerance: ± 0.050
Ground is backside of die

Bond Pad Description

Pad No.	Symbol	Pad Size (mm)	Description
1	RF IN	0.113 x 0.183	RF input. 50 Ohms. DC grounded.
2	VG	0.083 x 0.083	Gate voltage. Bypass network required.
3	VD	0.208 x 0.093	Drain voltage. Bypass network required.
4	VDET	0.090 x 0.090	Power detection. Bias not required.
5	RF OUT	0.113 x 0.183	RF output. 50 Ohms. DC blocked.

Assembly Notes

Component placement and adhesive attachment assembly notes:

- Vacuum pencils and/or vacuum collets are the preferred method of pick up.
- Air bridges must be avoided during placement.
- The force impact is critical during auto placement.

Reflow process assembly notes:

- Use AuSn (80/20) solder and limit exposure to temperatures above 300 °C to 3–4 minutes, maximum.
- An alloy station or conveyor furnace with reducing atmosphere should be used.
- Do not use any kind of flux.
- Coefficient of thermal expansion matching is critical for long-term reliability.
- Devices must be stored in a dry nitrogen atmosphere.

Interconnect process assembly notes:

- Thermosonic ball bonding is the preferred interconnect technique.
- Force, time, and ultrasonic are critical parameters.
- Aluminum wire should not be used.
- Devices with small pad sizes should be bonded with 0.0007-inch wire.

Handling Precautions

Parameter	Rating	Standard
ESD – Human Body Model (HBM)	1A	ANSI/ESD/JEDEC JS-001



Caution!
ESD-Sensitive Device

RoHS Compliance

This part is compliant with 2011/65/EU RoHS directive (Restrictions on the Use of Certain Hazardous Substances in Electrical and Electronic Equipment) as amended by Directive 2015/863/EU.

This product also has the following attributes:

- Lead Free
- Halogen Free (Chlorine, Bromine)
- Antimony Free
- TBBP-A (C₁₅H₁₂Br₄O₂) Free
- PFOS Free
- SVHC Free

Contact Information

For the latest specifications, additional product information, worldwide sales and distribution locations:

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Tel: 1-844-890-8163

Email: customer.support@qorvo.com

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Нашей специализацией является поставка электронной компонентной базы двойного назначения, продукции таких производителей как XILINX, Intel (ex.ALTERA), Vicor, Microchip, Texas Instruments, Analog Devices, Mini-Circuits, Amphenol, Glenair.

Сотрудничество с глобальными дистрибьюторами электронных компонентов, предоставляет возможность заказывать и получать с международных складов практически любой перечень компонентов в оптимальные для Вас сроки.

На всех этапах разработки и производства наши партнеры могут получить квалифицированную поддержку опытных инженеров.

Система менеджмента качества компании отвечает требованиям в соответствии с ГОСТ Р ИСО 9001, ГОСТ РВ 0015-002 и ЭС РД 009

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